

# C3M0120065J

## Silicon Carbide Power MOSFET

### C3M™ MOSFET Technology

#### N-Channel Enhancement Mode

#### Features

- 3<sup>rd</sup> Generation SiC MOSFET technology
- Low inductance package with driver source pin
- 7mm of creepage distance between drain and source
- High blocking voltage with low on-resistance
- High speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Qrr)
- Halogen free, RoHS compliant

#### Benefits

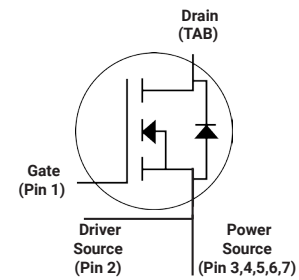
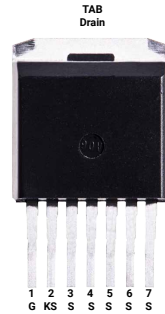
- Higher system efficiency
- Reduced cooling requirements
- Increased power density
- Increased system switching frequency
- Easy to parallel and simple to drive
- Enable new hard switching PFC topologies (Totem-Pole)

#### Applications

- Solar inverters
- DC/DC converters
- Switch Mode Power Supplies
- EV battery chargers
- UPS

$V_{DS}$	650 V
$I_D @ 25^\circ\text{C}$	21 A
$R_{DS(on)}$	120 mΩ

#### Package



Part Number	Package	Marking
C3M0120065J	TO-263-7	C3M0120065J

#### Maximum Ratings

Symbol	Parameter	Value	Unit	Note
$V_{DSS}$	Drain - Source Voltage, $T_c = 25^\circ\text{C}$	650	V	
$V_{GS}$	Gate - Source voltage (Under transient events < 100 ns)	-8/+19	V	Fig. 28
$I_D$	Continuous Drain Current, $V_{GS} = 15\text{ V}$ , $T_c = 25^\circ\text{C}$	21	A	Fig. 19
	Continuous Drain Current, $V_{GS} = 15\text{ V}$ , $T_c = 100^\circ\text{C}$	15		
$I_{D(pulse)}$	Pulsed Drain Current, Pulse width $t_p$ limited by $T_{jmax}$	51	A	
$P_D$	Power Dissipation, $T_c = 25^\circ\text{C}$ , $T_j = 175^\circ\text{C}$	86	W	Fig. 20
$T_j, T_{stg}$	Operating Junction and Storage Temperature	-40 to +175	$^\circ\text{C}$	
$T_L$	Solder Temperature, 1.6mm (0.063") from case for 10s	260	$^\circ\text{C}$	

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	650			V	$V_{GS} = 0\text{ V}, I_D = 100\ \mu\text{A}$	
$V_{GSon}$	Gate-Source Recommended Turn-On Voltage		15		V	Static	Fig. 29
$V_{GSoff}$	Gate-Source Recommended Turn-Off Voltage		-4		V		
$V_{GS(th)}$	Gate Threshold Voltage	1.8	2.3	3.6	V	$V_{DS} = V_{GS}, I_D = 1.86\ \text{mA}$	Fig. 11
			1.9		V	$V_{DS} = V_{GS}, I_D = 1.86\ \text{mA}, T_J = 175^\circ\text{C}$	
$I_{DSS}$	Zero Gate Voltage Drain Current		1	50	$\mu\text{A}$	$V_{DS} = 650\ \text{V}, V_{GS} = 0\ \text{V}$	
$I_{GSS}$	Gate-Source Leakage Current		10	250	nA	$V_{GS} = 15\ \text{V}, V_{DS} = 0\ \text{V}$	
$R_{DS(on)}$	Drain-Source On-State Resistance		120	157	m $\Omega$	$V_{GS} = 15\ \text{V}, I_D = 6.76\ \text{A}$	Fig. 4, 5, 6
			168			$V_{GS} = 15\ \text{V}, I_D = 6.76\ \text{A}, T_J = 175^\circ\text{C}$	
$g_{fs}$	Transconductance		5.0		S	$V_{DS} = 20\ \text{V}, I_{DS} = 6.76\ \text{A}$	Fig. 7
			4.9			$V_{DS} = 20\ \text{V}, I_{DS} = 6.76\ \text{A}, T_J = 175^\circ\text{C}$	
$C_{iss}$	Input Capacitance		640		pF	$V_{GS} = 0\ \text{V}, V_{DS} = 0\text{V to } 400\ \text{V}$	Fig. 17, 18
$C_{oss}$	Output Capacitance		45			$F = 1\ \text{Mhz}$	
$C_{rss}$	Reverse Transfer Capacitance		2.3			$V_{AC} = 25\ \text{mV}$	
$C_{o(er)}$	Effective Output Capacitance (Energy Related)		57			$V_{GS} = 0\ \text{V}, V_{DS} = 0\text{V to } 400\ \text{V}$	Note: 1
$C_{o(tr)}$	Effective Output Capacitance (Time Related)		79				Note: 1
$E_{oss}$	$C_{oss}$ Stored Energy		4.3		$\mu\text{J}$	$V_{DS} = 400\ \text{V}, F = 1\ \text{Mhz}$	Fig. 16
$E_{ON}$	Turn-On Switching Energy (Body Diode)		28		$\mu\text{J}$	$V_{DS} = 400\ \text{V}, V_{GS} = -4\ \text{V}/15\ \text{V}, I_D = 6.76\ \text{A}, R_{G(ext)} = 10\ \Omega, L = 237\ \mu\text{H}, T_J = 175^\circ\text{C}$	Fig. 25
$E_{OFF}$	Turn Off Switching Energy (Body Diode)		6			FWD = Internal Body Diode of MOSFET	
$t_{d(on)}$	Turn-On Delay Time		8		ns	$V_{DD} = 400\ \text{V}, V_{GS} = -4\ \text{V}/15\ \text{V}$ $I_D = 6.76\ \text{A}, R_{G(ext)} = 10\ \Omega$ Timing relative to $V_{DS}$ Inductive load	Fig. 26
$t_r$	Rise Time		9				
$t_{d(off)}$	Turn-Off Delay Time		18				
$t_f$	Fall Time		9				
$R_{G(int)}$	Internal Gate Resistance		6		$\Omega$	$f = 1\ \text{MHz}, V_{AC} = 25\ \text{mV}$	
$Q_{gs}$	Gate to Source Charge		8		nC	$V_{DS} = 400\ \text{V}, V_{GS} = -4\ \text{V}/15\ \text{V}$ $I_D = 6.76\ \text{A}$ Per IEC60747-8-4 pg 21	Fig. 12
$Q_{gd}$	Gate to Drain Charge		7				
$Q_g$	Total Gate Charge		26				

Note (1):  $C_{o(er)}$ , a lumped capacitance that gives same stored energy as  $C_{oss}$  while  $V_{ds}$  is rising from 0 to 400V

$C_{o(tr)}$ , a lumped capacitance that gives same charging time as  $C_{oss}$  while  $V_{ds}$  is rising from 0 to 400V

### Reverse Diode Characteristics ( $T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
$V_{SD}$	Diode Forward Voltage	4.5		V	$V_{GS} = -4\text{ V}, I_{SD} = 3.4\text{ A}, T_J = 25^\circ\text{C}$	Fig. 8, 9, 10
		4.0		V	$V_{GS} = -4\text{ V}, I_{SD} = 3.4\text{ A}, T_J = 175^\circ\text{C}$	
$I_S$	Continuous Diode Forward Current		15	A	$V_{GS} = -4\text{ V}, T_c = 25^\circ\text{C}$	
$I_{S, pulse}$	Diode pulse Current		51	A	$V_{GS} = -4\text{ V}$ , pulse width $t_p$ limited by $T_{jmax}$	
$t_{rr}$	Reverse Recover time	8		ns	$V_{GS} = -4\text{ V}, I_{SD} = 6.76\text{ A}, V_R = 400\text{ V}$ $diff/dt = 5470\text{ A}/\mu\text{s}, T_J = 175^\circ\text{C}$	
$Q_{rr}$	Reverse Recovery Charge	78		nC		
$I_{rrm}$	Peak Reverse Recovery Current	16		A		
$t_{rr}$	Reverse Recover time	9		ns	$V_{GS} = -4\text{ V}, I_{SD} = 6.76\text{ A}, V_R = 400\text{ V}$ $diff/dt = 3650\text{ A}/\mu\text{s}, T_J = 175^\circ\text{C}$	
$Q_{rr}$	Reverse Recovery Charge	41		nC		
$I_{rrm}$	Peak Reverse Recovery Current	7		A		

### Thermal Characteristics

Symbol	Parameter	Typ.	Unit	Test Conditions	Note
$R_{\theta JC}$	Thermal Resistance from Junction to Case	1.73	$^\circ\text{C}/\text{W}$		Fig. 21
$R_{\theta JA}$	Thermal Resistance From Junction to Ambient	40			

## Typical Performance

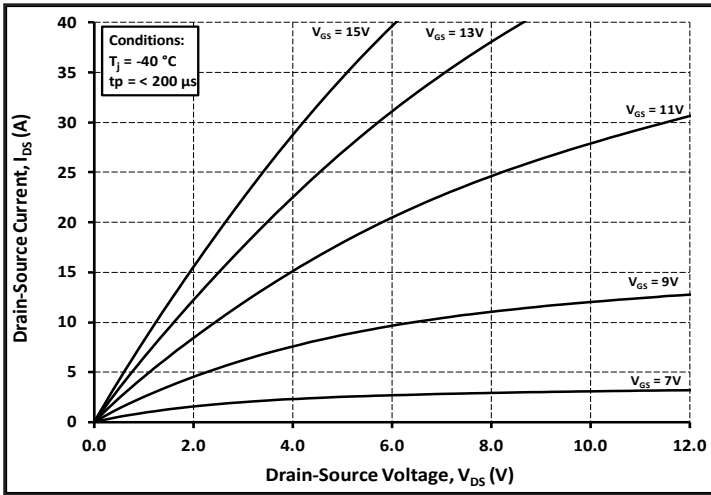


Figure 1. Output Characteristics  $T_J = -40\text{ }^\circ\text{C}$

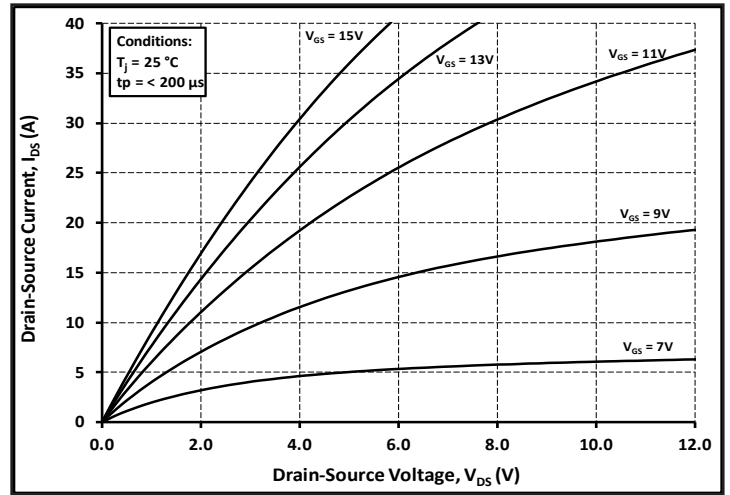


Figure 2. Output Characteristics  $T_J = 25\text{ }^\circ\text{C}$

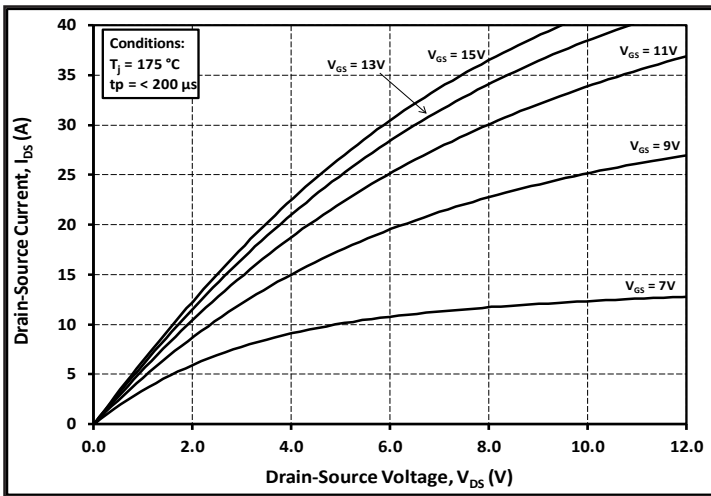


Figure 3. Output Characteristics  $T_J = 175\text{ }^\circ\text{C}$

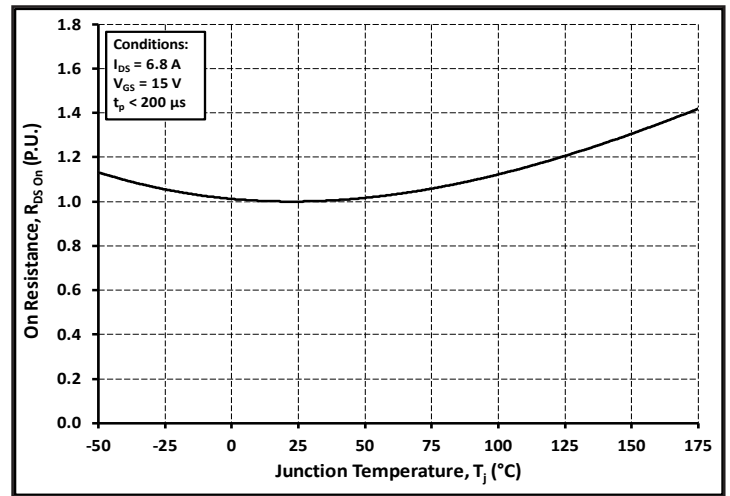


Figure 4. Normalized On-Resistance vs. Temperature

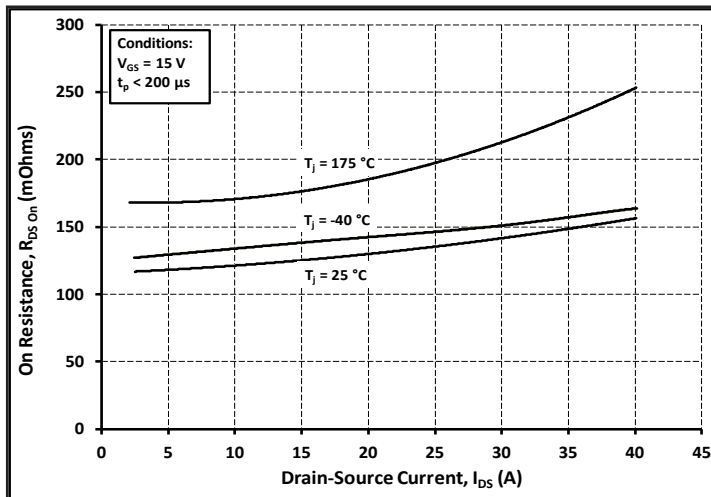


Figure 5. On-Resistance vs. Drain Current For Various Temperatures

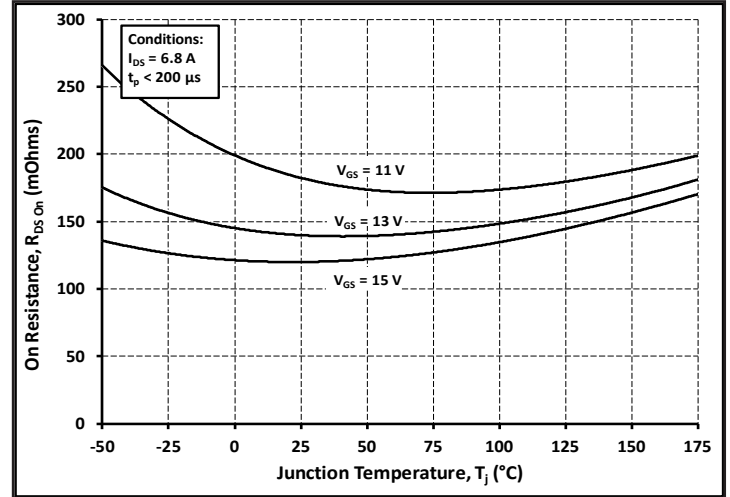


Figure 6. On-Resistance vs. Temperature For Various Gate Voltage

## Typical Performance

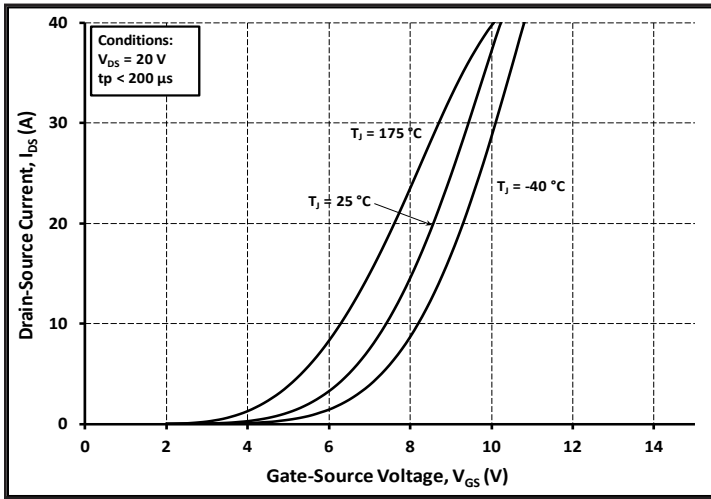


Figure 7. Transfer Characteristic for Various Junction Temperatures

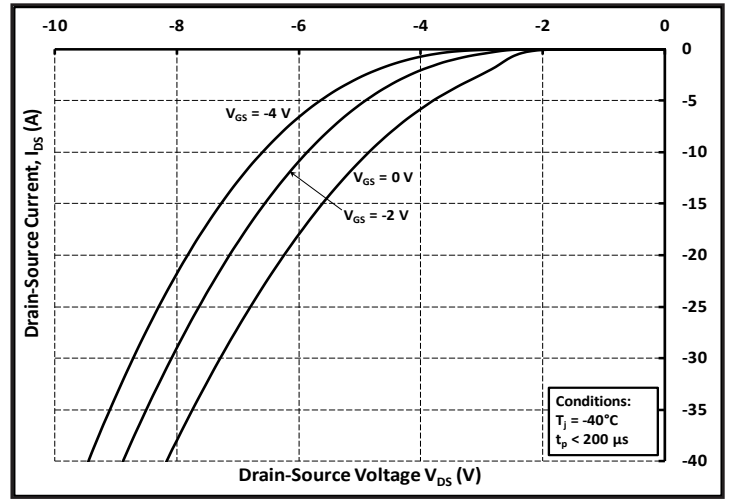


Figure 8. Body Diode Characteristic at  $-40\text{ °C}$

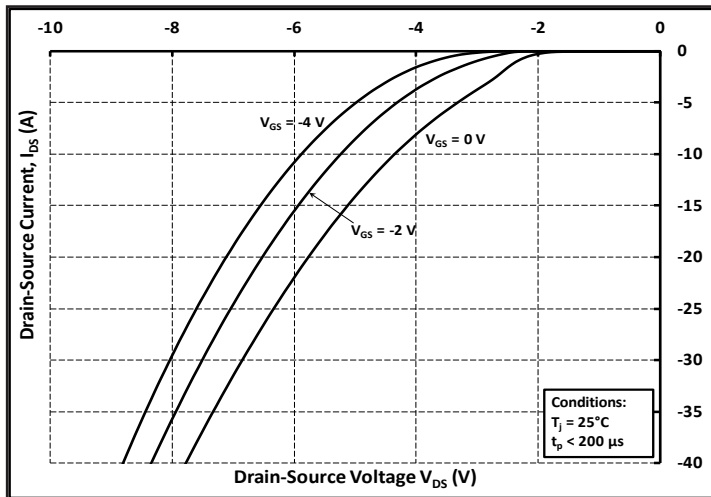


Figure 9. Body Diode Characteristic at  $25\text{ °C}$

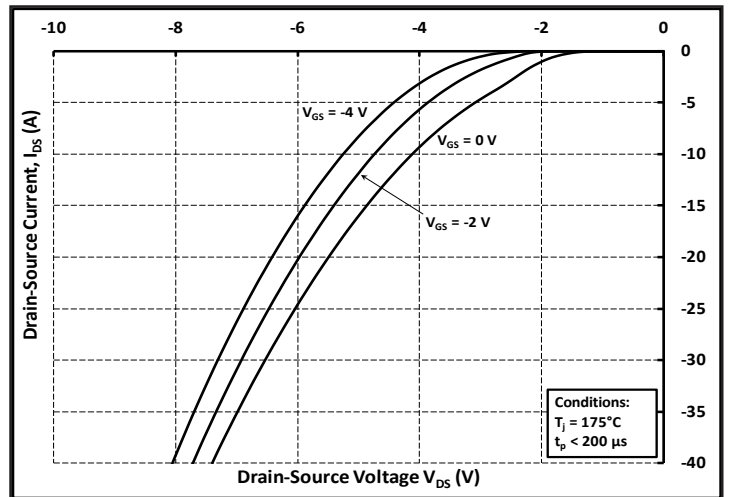


Figure 10. Body Diode Characteristic at  $175\text{ °C}$

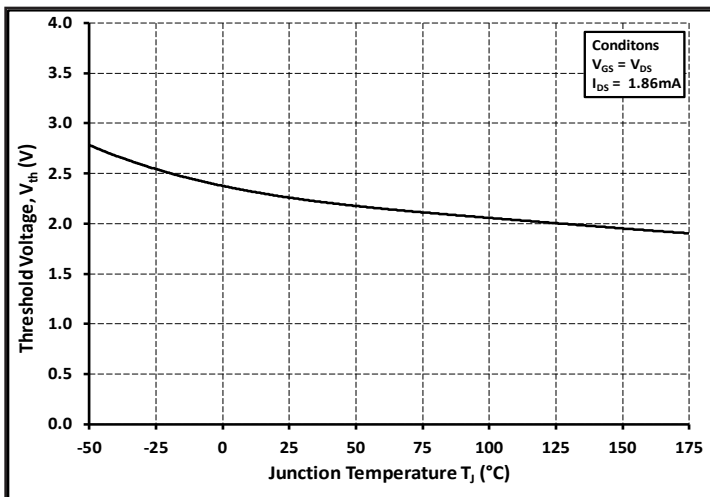


Figure 11. Threshold Voltage vs. Temperature

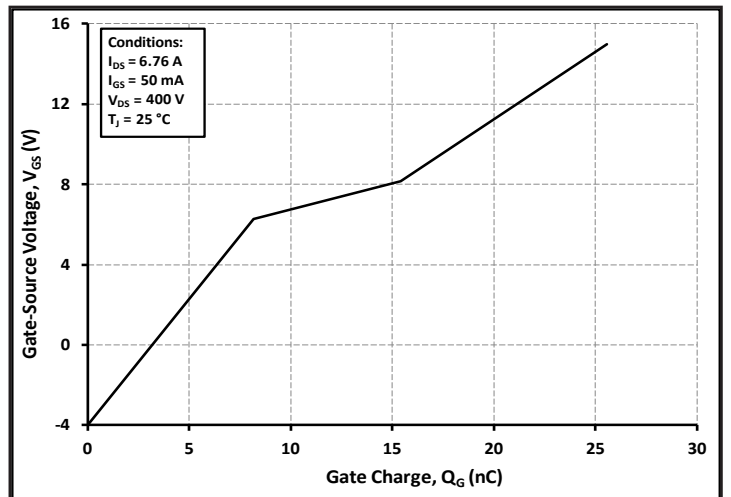


Figure 12. Gate Charge Characteristics

## Typical Performance

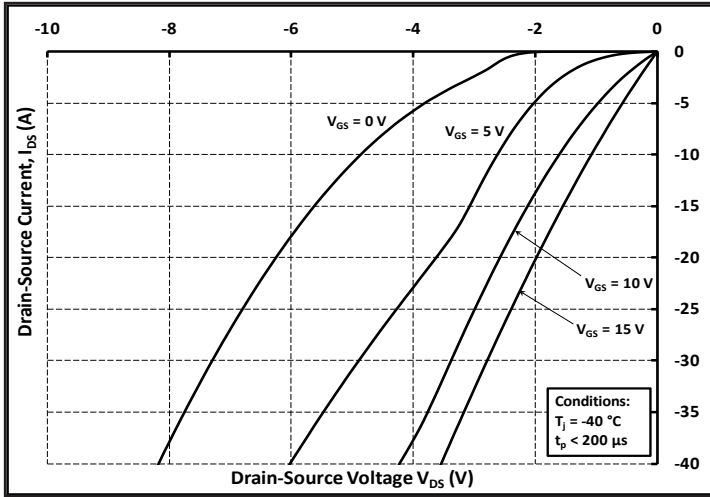


Figure 13. 3rd Quadrant Characteristic at -40 °C

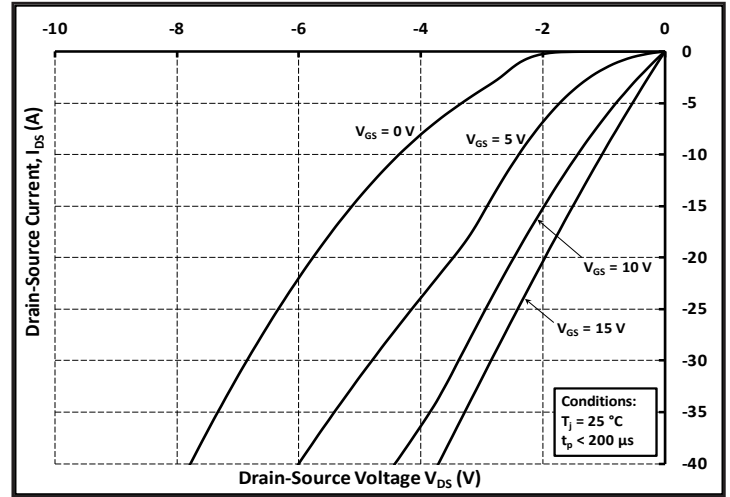


Figure 14. 3rd Quadrant Characteristic at 25 °C

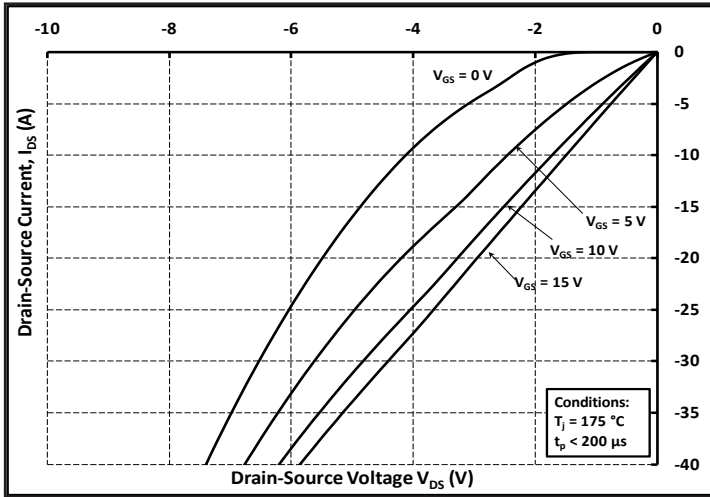


Figure 15. 3rd Quadrant Characteristic at 175 °C

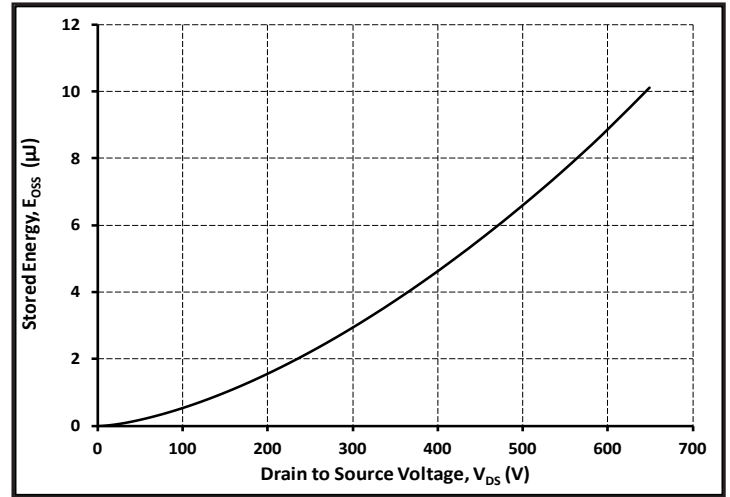


Figure 16. Output Capacitor Stored Energy

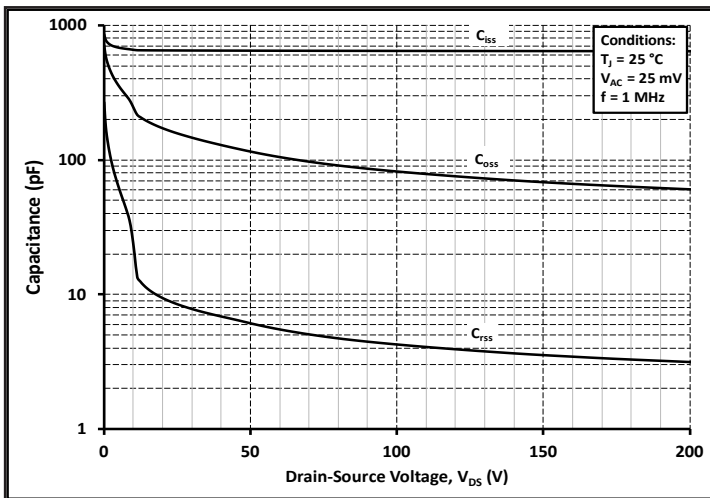


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

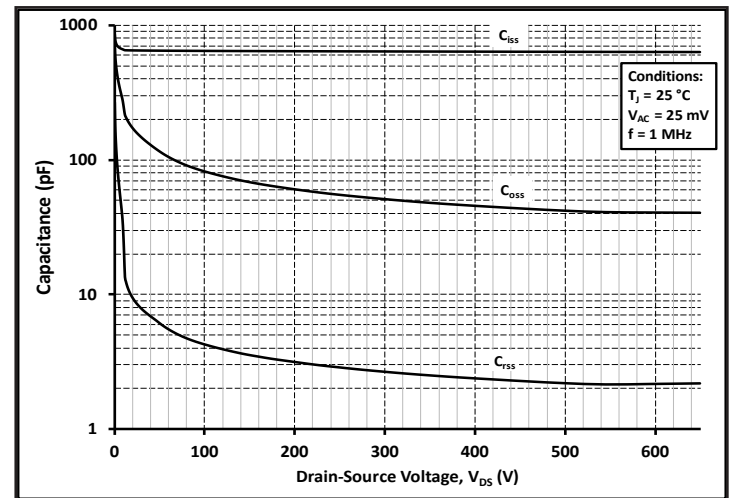


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 650V)

## Typical Performance

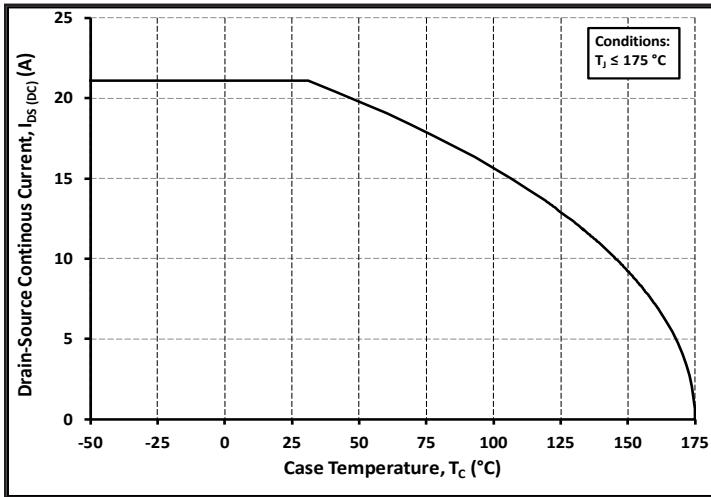


Figure 19. Continuous Drain Current Derating vs. Case Temperature

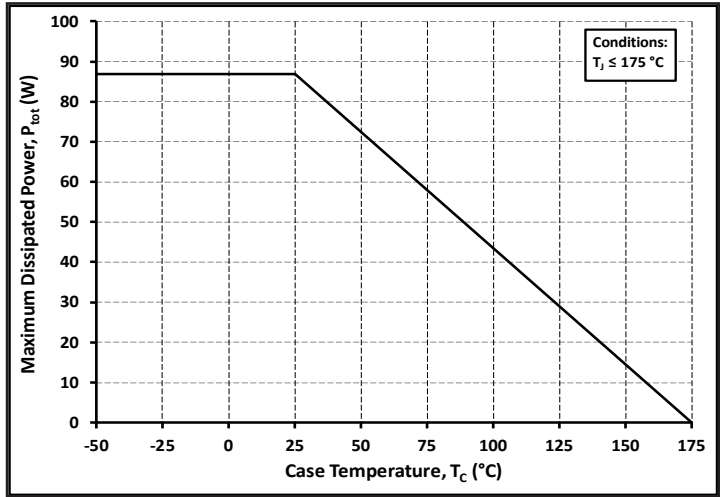


Figure 20. Maximum Power Dissipation Derating vs. Case Temperature

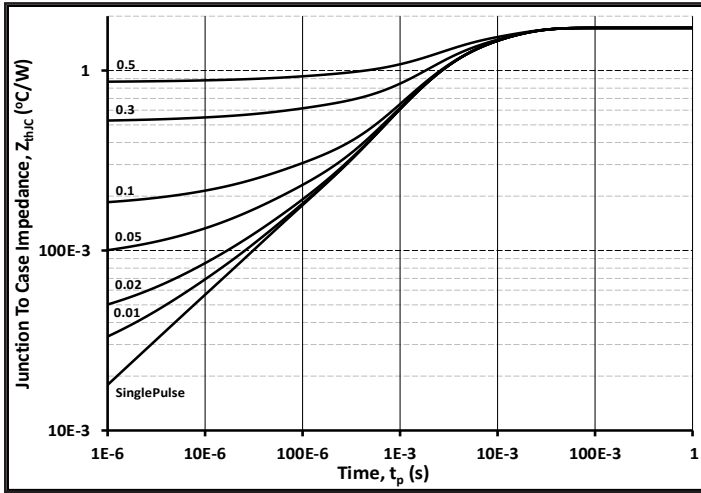


Figure 21. Transient Thermal Impedance (Junction - Case)

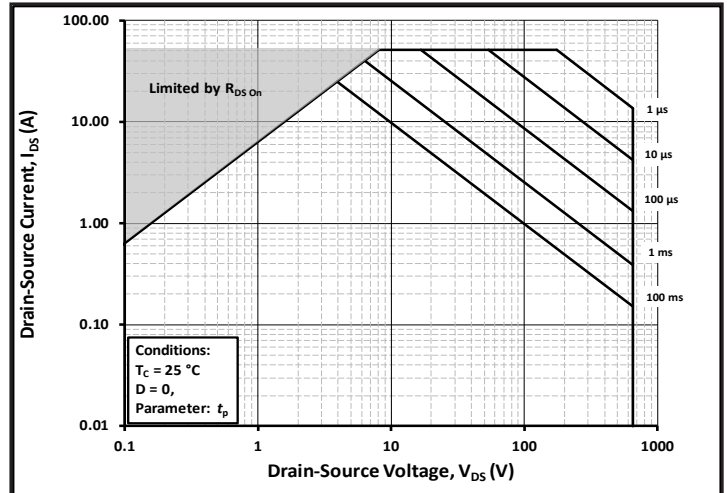


Figure 22. Safe Operating Area

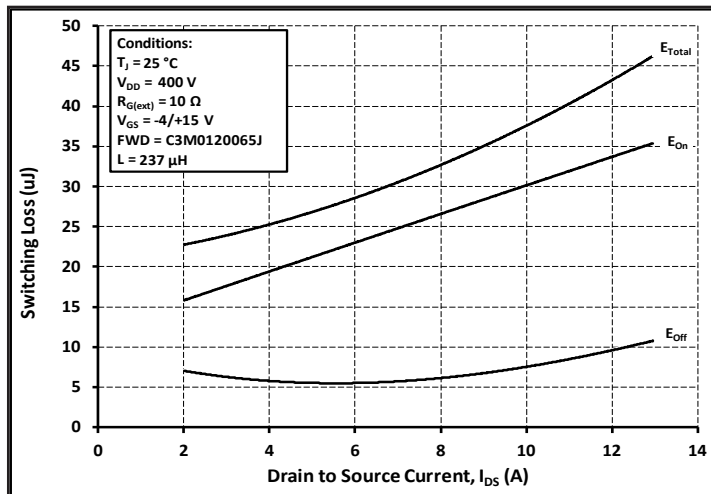


Figure 23. Clamped Inductive Switching Energy vs. Drain Current ( $V_{DD} = 400V$ )

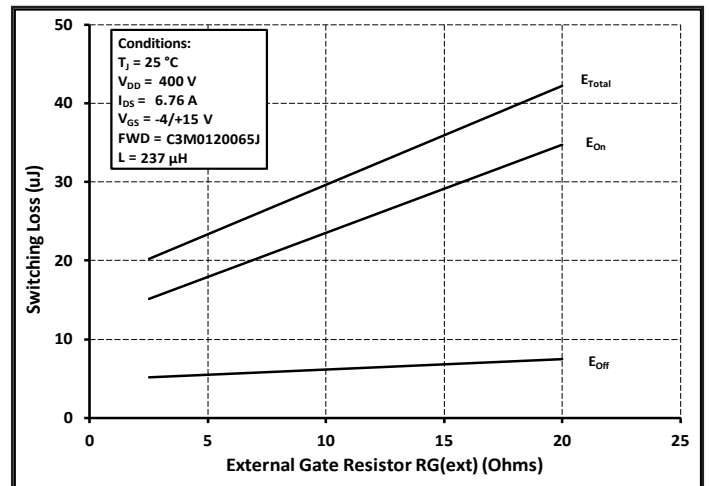


Figure 24. Clamped Inductive Switching Energy vs.  $R_{G(ext)}$

## Typical Performance

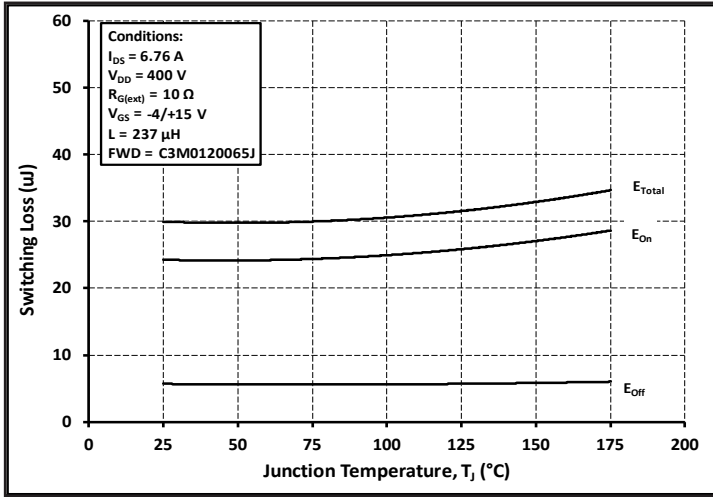


Figure 25. Clamped Inductive Switching Energy vs. Temperature

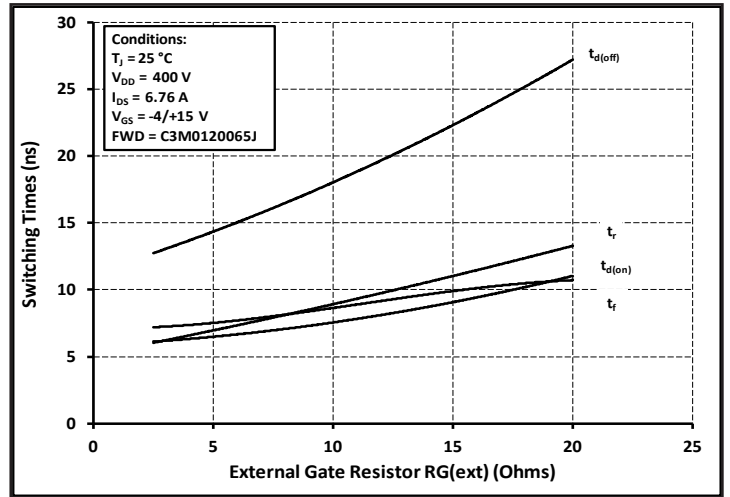


Figure 26. Switching Times vs.  $R_{G(ext)}$



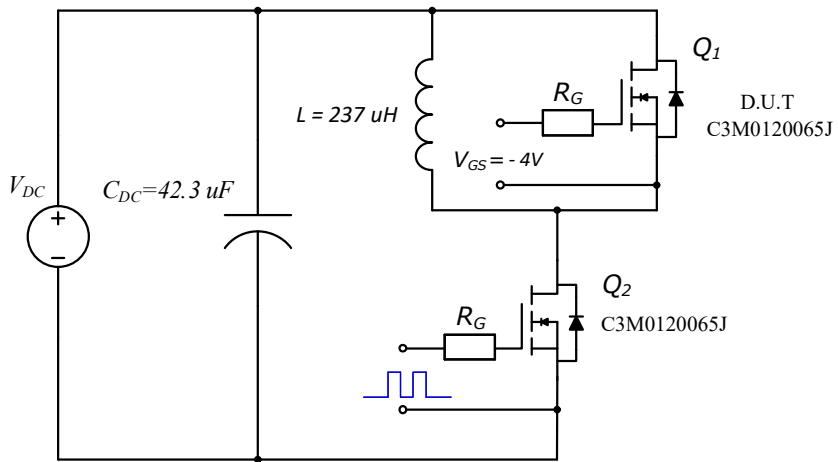


Figure 27. Clamped Inductive Switching Waveform Test Circuit

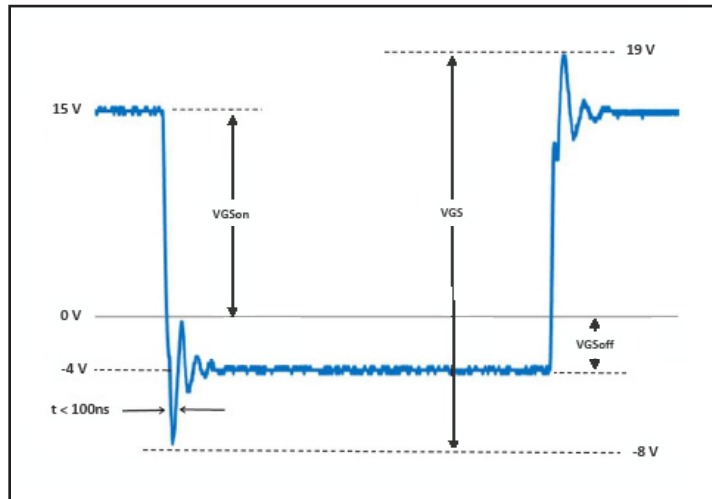
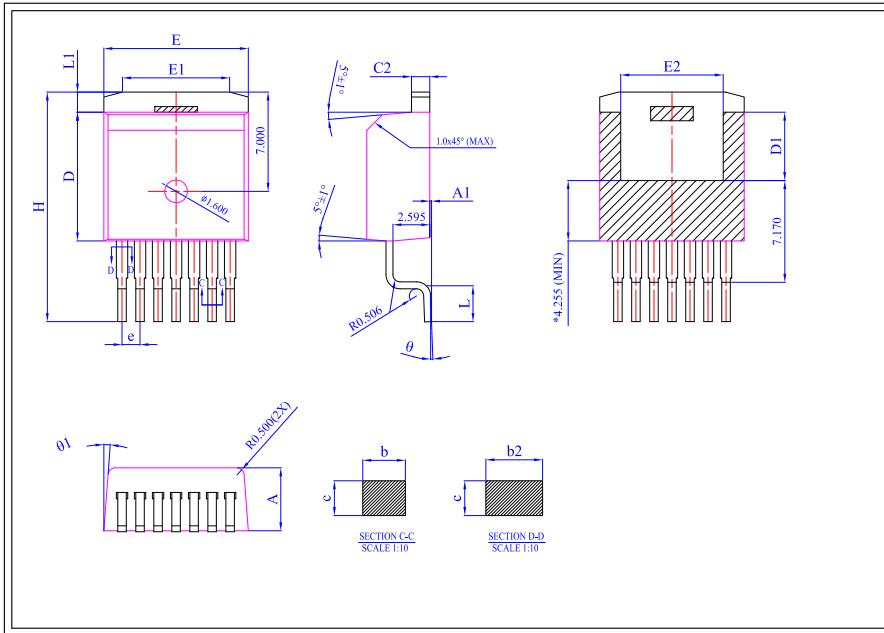


Figure 28.  $V_{GS}$  Waveform Example

## Package Dimensions

Package 7L D2PAK



Dim	All Dimensions in Millimeters		
	Min	typ	Max
A	4.300	4.435	4.570
A1	0.00	0.125	0.25
b	0.500	0.600	0.700
b2	0.600	0.800	1.000
c	0.330	0.490	0.650
C2	1.170	1.285	1.400
D	9.025	9.075	9.125
D1	4.700	4.800	4.900
E	10.130	10.180	10.230
E1	6.500	7.550	8.600
E2	6.778	7.223	7.665
e	1.27		
H	15.043	16.178	17.313
L	2.324	2.512	2.700
L1	0.968	1.418	1.868
$\theta$	$0^\circ$	$4^\circ$	$8^\circ$
$\phi 1$	$4.5^\circ$	$5^\circ$	$5.5^\circ$

